

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Yu Yamazaki et al.  
Serial No. : 10/724,872  
Filed : December 2, 2003  
Title : LIGHT EMITTING DEVICE

Art Unit : 2815  
Examiner : Joseph H Nguyen

**MAIL STOP RCE**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

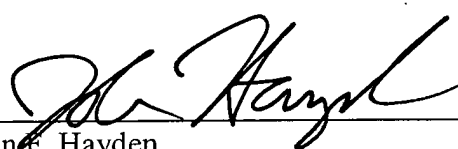
INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: 1/17/06

  
John F. Hayden  
Reg. No. 37,640

Customer No. 26171  
Fish & Richardson P.C.  
1425 K Street, N.W. - 11th Floor  
Washington, DC 20005-3500  
Telephone: (202) 783-5070  
Facsimile: (202) 783-2331  
/adt  
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<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yu Yamazaki et al.	
		Filing Date December 2, 2003	Group Art Unit 2815

### U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002-0044782	04/18/2002	Kota et al.			10/12/2001
	AB	2004-0245918	12/09/2004	Lee			05/21/2004
	AC	2004-0251823	12/16/2004	Park et al.			05/20/2004
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	AE	2005-0062407	03/24/2005	Suh et al.			08/10/2004
	AF						

### Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	AG	EP0 881 617	02 DEC 1998	EUROPE			In English	
	AH	JP01-253791	11 OCT 1989	JAPAN			Abstract	
	AI	JP02-134696	23 MAY 1990	JAPAN			Abstract	
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	AS	WO99-018590	15 APR 1999	WIPO / PCT			In English	

### Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AT	
	AU	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	